

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/802,096	<b>Applicant(s)/Patent under Reexamination</b> OSHIBA ET AL.
	<b>Examiner</b> John L. Goodrow	<b>Art Unit</b> 1756

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner